



## **Features**

- AEC-Q100 Grade 1 temperature range
- 44 fixed frequencies between 4 MHz and 125 MHz
- Supply voltage of 1.5 V, 1.8 V, 2.5 V and 3.3 V (Contact SiTime for 1.2 V)
- Low power consumption of 2.3 mA typical at 1.8 V
- LVCMOS compatible output
- 1 µA standby current
- 500 fs RMS phase jitter
- Industry-standard packages: 2.0 x 1.6, 2.5 x 2.0, 3.2 x 2.5 mm (Contact SiTime for 1.6 x 1.2 mm)
- RoHS and REACH compliant, Lead-free, Halogenfree and Antimony-free

## **Applications**

- Automotive Camera and Sensors, Smart Mirrors
- Advanced Driver Assistance Systems
- Automotive Infotainment Systems
- In-vehicle networking and SerDes
- Industrial sensors

Related products for automotive applications

For aerospace and defense applications SiTime recommends using only Endura™ ruggedized products



## **Electrical Specifications**

#### **Table 1. Electrical Characteristics**

All Min and Max limits are specified over temperature for all supply voltages with 15 pF output load unless otherwise stated. Typical values are specified at 25°C and at the nominal value of the highest voltage option for that parameter.

Parameters	Symbol	Min.	Тур.	Max.	Unit	Condition
			F	requency	Range	
Fixed Frequency Options f		5, 10, 20, 25, 31.25, 33.333333, 50, 62.5, 78.125, 100, 125		MHz	SiT1625A	
	4, 4.096, 6, 8, 8.192, 9, 12, 16, 18, 18.432, 19.2, 24, 24.576, 30.72, 32, 32.768, 36, 38.4, 48, 61.44, 64, 72, 76.8, 96, 122.88			SiT1625B		
		7, 13,	, 21, 27, 3 91, 117	9, 63,		SiT1625C
			Frequer	ncy Stabil	ity and A	ging
Frequency Stability	F_stab	-50	_	+50	ppm	Inclusive of Initial tolerance at 25°C, 1st year aging at 25°C, and variations over operating temperature -40°C to 125°C, rated power supply voltage and load (15 pF ±10%)
		-30	-	+30		Supported for -40°C to 105°C
		-25	_	+25		Supported for -40°C to 85°C
			Operati	ng Tempe	erature Ra	ange
Operating Temperature	T_use	-40	-	+125	°C	AEC-Q100 Grade1
Range		-40	-	+105	°C	AEC-Q100 Grade2
		-40	-	+85	°C	AEC-Q100 Grade 3
		Sup	ply Voltag	e and Cu	rrent Cor	nsumption
Supply Voltage	Vdd	1.35	1.5	1.65	V	Contact SiTime for 1.2 V and 5 V options (±5%)
		1.62	1.8	1.98		
		2.25	2.5	2.75		
		2.97	3.3	3.63	1	
		2.25	_	3.63	1	
Current Consumption	ldd	-	2.3	_	mA	f = 27 MHz, no load, 1.8 V
Standby Current	I_std	-	2.0	_	uA	Up to 125°C
		-	1.0	-		Up to 105°C



Table 1. Electrical Characteristics (continued)

Parameters	Symbol	Min.	Тур.	Max.	Unit	Condition
LVCMOS Output Characteristics						
Duty Cycle	DC	45	-	55	%	All Vdd levels
Rise/Fall Time	Tr, Tf	-	-	2.1	ns	Vdd = 1.62 V - 3.63 V, 20% - 80%, 15 pF Load
Output High Voltage	VOH	90%	ı	ı	Vdd	IOH = -4 mA (Vdd = 3.0 V or 3.3 V) IOH = -3 mA (Vdd = 2.8 V and Vdd = 2.5 V) IOH = -2 mA (Vdd = 1.8 V)
Output Low Voltage	VOL	I	ı	10%	Vdd	IOL = 4 mA (Vdd = 3.0 V or 3.3 V) IOL = 3 mA (Vdd = 2.8 V and Vdd = 2.5 V) IOL = 2 mA (Vdd = 1.8 V)
			Startu	p and Re	sume Tir	ning
Startup Time	T_start	ı	0.7	1	ms	Measured from the time Vdd reaches its rated minimum value
Enable/Disable Time	T_oe	1	210	1	ns	f = 27 MHz. For other frequencies, T_oe = 100 ns + 3*cycles
Resume Time (Standby)	T_resume	1	0.7	ı	ms	
			Jitt	er and Pl	nase Nois	se
RMS Period Jitter[1]	T_jitt	-	1	-	ps	f = 27 MHz
RMS Phase Jitter (random)[2]	T_phj_fc_2	ı	0.55	ı	ps	f = 27 MHz, 12 kHz – 20 MHz integration bandwidth, phase noise measured 12 kHz – 13.5 MHz and extended flat above 13.5 MHz
	T_phj_5	ı	0.5	ı	ps	f = 27 MHz, 12 kHz – 5 MHz integration bandwidth, phase noise measured 12 kHz – 5 MHz
Phase Noise	PN	ı	-143	ı	dBc/Hz	f = 27 MHz, f_offset = 100 kHz
Spurious Phase Noise	T_spn	ı	-85	ı	dBc	f = 27 MHz, 1.8 V, 12 kHz - 5 MHz offset frequency range
Power Supply-Induced Jitter Sensitivity	PSJS	-	0.4	-	ps/mV	50 mV peak-peak on Vdd = 3.3 V

#### Note:

- 1. Appropriate when driving digital logic for use in setup and hold time equations.
- 2. Appropriate when driving phase locked loops in high-speed SerDes applications.

#### **Table 2. Absolute Maximum Limits**

Operation outside the absolute maximum ratings may cause permanent damage to the part.

Performance of the IC is only guaranteed within the operational specifications, not at absolute maximum ratings.

Parameter	Min.	Max.	Unit
Storage Temperature	-65	150	°C
Supply Voltage (Vdd)	-0.5	4	V
Electrostatic Discharge (HBM)	-	2000	V
Electrostatic Discharge (CDM)	-	750	V
Soldering Temperature (follow standard Pb free soldering guidelines) <sup>[3]</sup>	-	260	°C
Junction Temperature <sup>[4]</sup>	-	150	°C

#### Note:

- 3. Please refer to SiTime Manufacturing Notes.
- 4. Exceeding this temperature for extended period of time may damage the device.

Table 3. Thermal Considerations<sup>[5]</sup>

Package	θJA, 4 Layer Board (°C/W)	θJA, 2 Layer Board (°C/W)	θJC, Bottom (°C/W)
3225	TBD	TBD	TBD
2520	TBD	TBD	TBD
2016	TBD	TBD	TBD
1612	TBD	TBD	TBD

#### Note:

5. θ<sub>JA</sub>, Ψ<sub>JT</sub>, θ<sub>JB</sub> and θ<sub>JC</sub> are provided according to JEDEC standards 51-2A, 51-7, 51-8, and 51-12.01 with a 25°C ambient and 250 mW power consumption (typical of 1 GHz f<sub>out</sub>). The conduction thermal resistances θ<sub>JB</sub> and θ<sub>JC</sub> are obtained with the assumption that all heat flows from the junction to a heat sink through either the solder pads (θ<sub>JB</sub>) or the top of the package (θ<sub>JC,Top</sub>). These may be used in a two-resistor compact model. The values of θ<sub>JA</sub> and Ψ<sub>JT</sub> are strongly application dependent, and we report values based on the JEDEC thermal environment. θ<sub>JA</sub> is the thermal resistance to ambient on a JEDEC PCB - it is a highly conservative estimate, since the JEDEC board does not have vias to PCB planes in the vicinity of the package. Ψ<sub>JT</sub> can be used to estimate the junction temperature from measurements of the temperature at the top of the package if the thermal environment is similar to the JEDEC environment.



Table 4. Maximum Operating Junction Temperature<sup>[6]</sup>

Max Operating Temperature (ambient)	Maximum Operating Junction Temperature
85°C	TBD
105°C	TBD
125°C	TBD

#### Note:

6. Datasheet specifications are not guaranteed if junction temperature exceeds the maximum operating junction temperature.

## **Table 5. Environmental Compliance**

Parameter	Condition/Test Method
Mechanical Shock	MIL-STD-883F, Method 2002
Mechanical Vibration	MIL-STD-883F, Method 2007
Temperature Cycle	JESD22, Method A104
Solderability	MIL-STD-883F, Method 2003
Moisture Sensitivity Level	MSL1 @ 260°C

## **Pin Description**

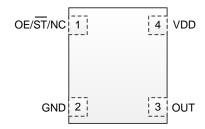


Figure 1. Pin Assignments (Top View)

## **Table 6. Pin Description**

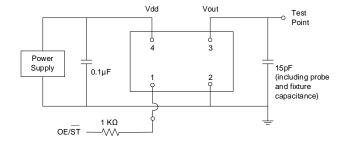
Pin	Symbol		Function
Ou		Output Enable (OE)	H <sup>[7]</sup> : specified frequency output L: output is high impedance. Only output driver is disabled
1	1 OE/ST/NC	Stability ( ST )	H <sup>[7]</sup> : specified frequency output L: output is low (weak pull down). Device goes to sleep mode
		No Connect (NC)	Any voltage between GND and Vdd or Open <sup>[8]</sup> . Specified frequency output. Pin 1 has no function.
2	GND	Power	Electrical ground <sup>[8]</sup>
3	OUT	Output	Oscillator output
4	VDD	Power	Power supply voltage <sup>[8]</sup>

#### Notes:

- 7. In OE or  $\overline{ST}$  mode, a pull-up resistor of 10 K $\Omega$  or less is recommended if pin 1 is not externally driven. If pin 1 needs to be left floating, use the NC option.
- 8. A capacitor of value 0.1  $\mu\text{F}$  between VDD and GND is required.



## **Test Circuit and Waveform**



80% Vdd 50% 20% Vdd High Pulse Low Pulse (TH) (TL) Period

Figure 2. Test Circuit<sup>[9]</sup>

Figure 3. Waveform<sup>[9]</sup>

Note:

9. Duty Cycle is computed as Duty Cycle = TH/Period.

## **Timing Diagrams**

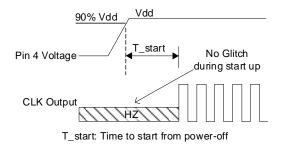
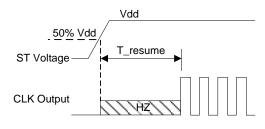
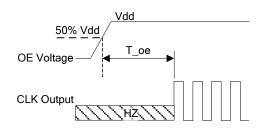


Figure 4. Startup Timing (OE/ST Mode)[10]



T resume: Time to resume from ST

Figure 5. Standby Resume Timing (ST Mode Only)[10]



T\_oe: Time to re-enable the clock output

Vdd OE Voltage 50% Vdd T\_oe **CLK Output** 

T\_oe: Time to put the output in High Z mode

Figure 6. OE Enable Timing (OE Mode Only)

Figure 7. OE Disable Timing (OE Mode Only)

Note:

10. SiT1625 has "no runt" pulses and "no glitch" output during startup or resume.



## **Programmable Drive Strength**

The SiT1625 includes a programmable drive strength feature to provide a simple, flexible tool to optimize the clock rise/fall time for specific applications. Benefits from the programmable drive strength feature are:

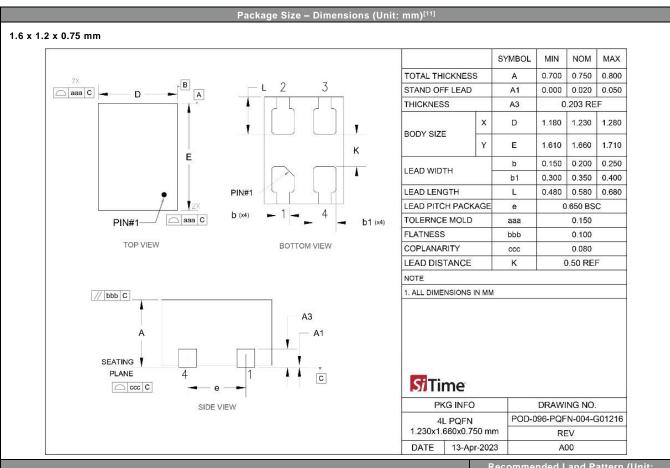
- Improves system radiated electromagnetic interference (EMI) by slowing down the clock rise/fall time.
- Improves the downstream clock receiver's (RX) jitter by decreasing (speeding up) the clock rise/fall time.
- Ability to drive large capacitive loads while maintaining full swing with sharp edge rates.

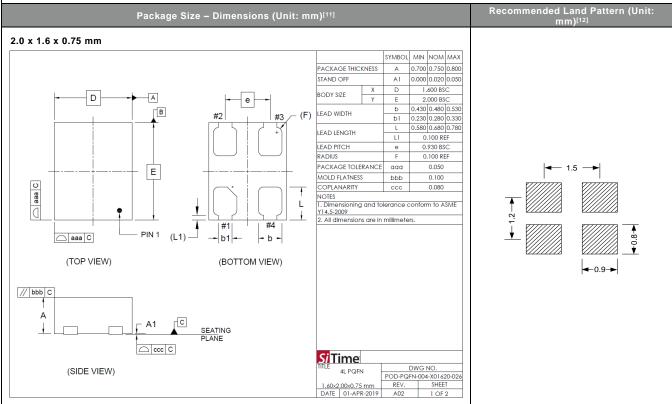
Table 1 reflects the default drive strength which is optimized for fastest rise/fall times.

For more detailed information about rise/fall time control and drive strength selection, contact SiTime.



## **Dimensions and Patterns**

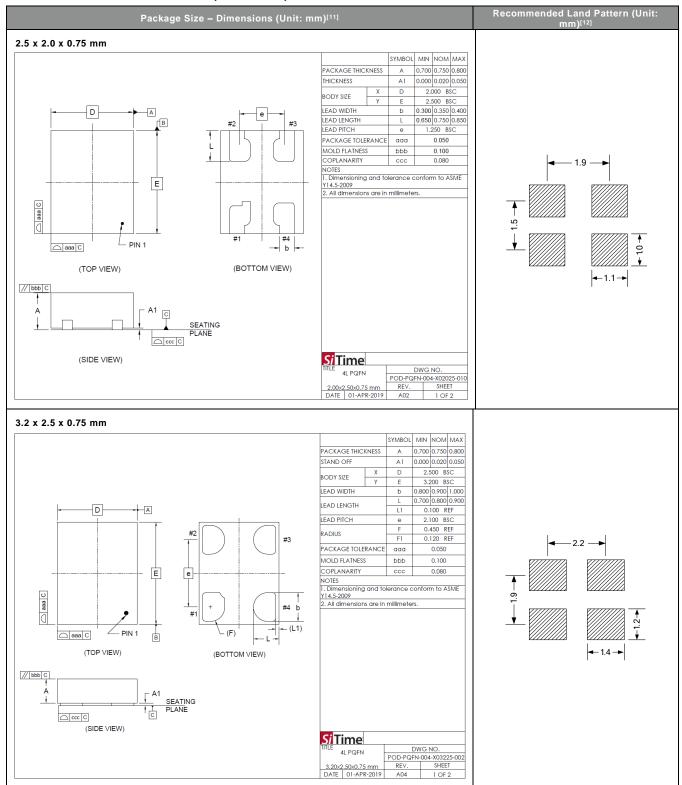








## **Dimensions and Patterns (continued)**



## Notes:

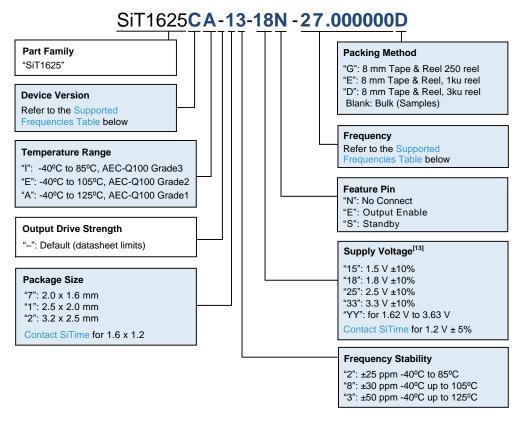
- 11. Top marking: Y denotes manufacturing origin and XXXX denotes manufacturing lot number. The value of "Y" will depend on the assembly location of the device.
- 12. A capacitor of value 0.1 pF or higher between VDD and GND is required.





## **Ordering Information**

The part number guide illustrated below is for reference only, in which boxes identify order codes having more than one option. To customize and build an exact part number, use the SiTime Part Number Generator. To validate the part number, use the SiTime Part Number Decoder.



#### Note:

13. The voltage portion of the SiT1625 part number consists of a two-digit number that denotes the specific supply voltage of the device. Alternatively, "YY" can be used to indicate the entire operating voltage range from 1.62 V to 3.63 V.

Table 7. Part Number and Supported Frequencies<sup>[14,15]</sup>

	Frequency Range (MHz)						
SiT1	625A		SiT1625B SiT1625C				625C
5.000000	50.000000	4.000000	16.000000	32.000000	72.000000	7.000000	39.000000
10.000000	62.500000	4.096000	18.000000	32.768000	76.800000	13.000000	63.000000
20.000000	78.125000	6.000000	18.432000	36.000000	96.000000	21.000000	91.000000
25.000000	100.000000	8.000000	19.20000	38.400000	122.880000	27.000000	117.000000
31.250000	125.000000	8.192000	24.000000	48.000000	-	-	-
33.333333	-	9.000000	24.576000	61.440000	-	-	-
-	=	12.000000	30.720000	64.000000	-	-	-

#### Notes:

- 14. Any frequency the table above is supported with 6 decimal places of accuracy.
- 15. Please contact SiTime for frequencies that are not listed in the tables above.

Table 8. Ordering Codes for Supported Tape & Reel Packing Method

Device Size (mm²)	8 mm T&R (3ku)	8 mm T&R (1ku)	8 mm T&R (250u)
1.6 x 1.2	D	Е	G
2.0 x 1.6	D	E	G
2.5 x 2.0	D	E	G
3.2 x 2.5	D	Е	G



# Instant Samples with Time Machine and Field Programmable Oscillator

SiTime supports a field programmable version of the SiT1625 for fast prototyping and real time customization of features. The field programmable devices (FP devices) are available for all standard SiT1625 package sizes and can be configured to one's exact specification using the Time Machine II.

For more information regarding SiTime's field programmable solutions, see Time Machine II and Field Programmable devices.

SiT1625 is typically factory-programmed per customer ordering codes for volume delivery.



## Additional Information

## **Table 9. Additional Information**

Document	Description	Download Link
Time Machine II	Asterix programmer for engineering samples	https://www.sitime.com/time-machine-oscillator-and-active- resonator-programmer
Field Programmable Oscillators	Devices that can be programmable in the field by Time Machine II	https://www.sitime.com/support/resource-library/datasheets/field-programmable-oscillators-and-active-resonators-datasheet
Manufacturing Notes	Tape & Reel dimension, reflow profile and other manufacturing related info	https://www.sitime.com/sites/default/files/gated/Manufacturing-Notes-for-SiTime-Products.pdf
Qualification Reports	RoHS report, reliability reports, composition reports	http://www.sitime.com/support/quality-and-reliability
Performance Reports	Additional performance data such as phase noise, current consumption and jitter for selected frequencies	http://www.sitime.com/support/performance-measurement-report
Termination Techniques	Termination design recommendations	http://www.sitime.com/support/application-notes
Layout Techniques	Layout recommendations	http://www.sitime.com/support/application-notes

## **Revision History**

## **Table 10. Revision History**

Version	Release Date	Change Summary	
0.1	3-Feb-2022	Initial release	
0.22	15-Aug-2022	General Updates	
0.23	21-Sep-2022	Additional updates on typos	
0.24	30-Oct-2022	Formatting updates	
0.25	6-Nov-2022	Adjusted frequency and package options	
		Updated jitter and phase noise specifications	
0.26	11-Feb-2023	Added clarifying notes to jitter and phase noise specifications	
0.5	11-Feb-2023	Updated Features and Applications, Electrical Characteristics, Pin Descriptions, Ordering Information	
0.51	22-Feb-2023	Updated Electrical Characteristics	
0.52	19-Apr-2023	Added 1612 package option	
0.6	27-Jul-2023	Expanded Supported Frequencies, Updated Table 1 specs, Added Programmable Drive Strength Section, Reorganized Sections, Typo corrections, Updated Ordering Information, Updated ESD spec	

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